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BRANCH ADDRESS:

BRANCHES AT : BENGALURU, BHOPAL, BHUBANESHWAR, CHANDIGARH, CHENNAI, GUWAHATI, HYDERABAD, JAIPUR, KOLKATA, LUCKNOW, MUMBAI, NEW DELHI, PATNA & THIRUVANANTHAPURAM.

1 nm **Bandwidth** SYSTRONICS UV - VIS SPECTROPHOTOMETER 117 is a micro controller based single beam scanning standalone instrument & UV - VIS SPECTROPHOTOMETER 119 PC based instrument. Both are offers 1 nm bandwidth. It provides three measuring modes: Percent Transmittance (%T), Absorbance (ABS) and Concentration (CONC) with factors. The available operating modes are Single-Wavelength, Multi-Wavelength, Spectrum Scan and Time Scan.

117 is Combination of user friendly software, 20 X 4 alphanumeric LCD display, covers wavelength 200-1100 nm. All measurement results are available on the display except for the Spectrum Scan. A printer prints the scan besides providing hard copy of measurements. RS-232 is optional to enhance data processing ability through PC.

119 is covers the wavelength range from 200-1000 nm Special software supports Multi-standard Calibration with linear or nonlinear curve fitting for concentration measurements, besides the K-factor method. The Personal Computer & application software enhance the data processing ability and offer: Peak-Pick, Point-Pick, Expansion of Spectra, Overlaying of Spectra, 1st to 4th Derivatives, Averaging of two Scans, Subtraction of two Scans, Concentration Calculations, Spectrum Store / Recall etc.

Both instruments having automatic base line correction such as scans the blank / reference and stores its spectrum in memory to give the base line correction when a sample is scanned. User friendly menu driven operation & self-diagnostic wavelength calibration while switch on the power of the instruments. The instruments are modified Czerny-Monochromatic geometry for better aberration correction, holographic grating 1200 lines / mm blazed at 250 nm. with automatic selection of four glass filters to eliminate spectral order interference.

SPECIFICATIONS	117
OPTICS	: Single Beam
Grating	: 1200 Lines / mm
WAVELENGTH	
Range	: 200 to 1100 nm
Resolution	: 0.1 nm
Accuracy	: ±0.5 nm
Repeatability	: ±0.2 nm
Bandwidth	: 1 nm
PHOTOMETRIC	
Range	: 0 to 3 Abs
Accuracy	: ± 0.005 Abs at 1A
Repeatability	: ± 0.002 Abs at 1A
Drift	: 0.003 Abs /hr. (After 1 hr. warmup at 500 nm)
STRAY LIGHT	: Less then 0.1% T at 220 nm & 340 nm
MEASURING MODES	
	: % Transmittance
	: Absorbance
	: Concentration (K-factor, Multi standard up to 5)
OPERATING MODES	: Single Wavelength
	: Multi Wavelength
	: Spectrum Scan
	: Time Scan
SOURCE	: Tungsten Halogen Lamp (320 to 1100 nm)
	Deuterium Lamp (200 to 340 nm)
SCAN SPEED	: Slow, Medium and Fast
DETECTOR	: UV-enhanced wide range solid state Si-photodiode
	: Automatic baseline correction
BASELINE FLATNESS	: ±0.003 Abs / hr. (After 40 minutes warm-ups)
DATA PROCESSING	: Stand Alone • Peak-Pick • Spectrum printout
DISPLAY	: 20 character, 4 line backlit alphanumeric LCD
KEYBOARD	: 18 keys (11 numeric and 7 functional)
DATA INTERVAL	: Depends on wavelength Scan-span & Scan-speed
SAMPLE HOLDER	: 5 position for 10 mm cuvette (automatically)
PRINTER PORT	: Epson compatible 80 Column D. M. Printer
RS-232 PORT	: PC Link data transfer
POWER	: 230V ±10%, 50 Hz
DIMENSIONS	: 745 (W) X 480 (D) X 200 (H) mm
WEIGHT	: 24 kg
ACCESSORIES	: Two matched 10 mm pathlength Quartz cuvettes,
	dust cover & manual
OPTIONAL ACCESSORIE	

OPTIONAL ACCESSORIES

- Holder for 50 mm or 100 mm cylindrical and rectangular cuvettes
- Personal Computer / Laptop
- Epson compatible 80 column D.M. Printer
- PC link Software for Spectrum Display, Storage/Retrieve, Peak -Pick, Point Pick, Expansion of spectra, 1st, 2nd, 3rd & 4th Derivatives, Averaging of Scans, Subtraction of Two Scans & Special software for kinetic by standard / factor

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OPTICS	: Single Beam
Grating	: 1200 Lines / mm
WAVELENGTH	
Range	: 200 to 1000 nm
Resolution	: 0.1 nm
Accuracy	: ±0.5 nm
Repeatability	: ±0.2 nm
Bandwidth	: 1 nm
PHOTOMETRIC	
Range	: -0.3 to 2.5 Abs, 0 to 100% T
Accuracy	: ± 0.005 Abs at 1A
Repeatability	: ± 0.002 Abs at 1A
Drift	: 0.003 Abs /hr. (After 1 hr. warmup at 500 nm)
STRAY LIGHT	: Less then 0.1% T at 220 nm & 340 nm
MEASURING MODES	
	: % Transmittance
	: Absorbance
	: Concentration (K-factor, Multi standard up to 5)
OPERATING MODES	: Single Wavelength
	: Multi Wavelength
	: Scan (with Multiscan facility)
	: Time Scan
SOURCE	: Tungsten Halogen Lamp (320 to 1000 nm)
	Deuterium Lamp (200 to 340 nm)
SCAN SPEED	: Slow, Medium and Fast (minimum at a span of 100 nm
DETECTOR	: UV - enhanced wide range solid state Si-photodiode
	N : Automatic baseline correction
BASELINE FLATNESS	: ±0.003 Abs / hr. (After 40 minutes warm-ups)
DATA PROCESSING	: • Peak Pick, Point Pick, Valley Pick
	 Zoom / Overlaying of Spectra
	 1st, 2nd, 3rd & 4th Derivatives
	 Averaging of Two Scans
	 Subtraction of Two Scans
	 Spectrum Store/Recall
	 Concentration of scan compared to base scans
DATA PRESENTATION	: Display of graphic and tabular data on computer
	monitor, Permanent data storage on hard disk, Hard
	Copy of graphic and tabular data on printer
SAMPLE HOLDER	: 5 position for 10 mm cuvette (automatically)
POWER	: 230V ±10%, 50 Hz
DIMENSIONS	: 745 (W) X 480 (D) X 200 (H) mm
WEIGHT	: 24 kg
ACCESSORIES	: Two matched 10 mm pathlength Quartz cuvettes,
	Dust cover & Manual

OPTIONAL ACCESSORIES

- Holder for 50 mm or 100 mm cylindrical and rectangular cuvettes
- Personal Computer / Laptop
- Any printer compatible with PC operating system